Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/681,269	LEE ET AL.	
Examiner	**Art Unit**	
Hai L. Nguyen	2816	

SEARCHED			
Class	Subclass	Date	Examiner
331	16,17,34, 175,177, 184	4/2/2005	HLN
330	258		
327	536,537		
—	589,148		
—	157,390		
Update Search		9/12/2005	HLN
all of above			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Consulted with Kenneth Wells, Primary Examiner, AU #2816	9/12/2005	HLN
Consulted with Christine Oda, QA	9/13/2005	HLN